

# MOSFET - Power, Single N-Channel, D<sup>2</sup>PAK

# 650 V, 82 mΩ, 40 A

# NVB082N65S3F

# **Description**

SUPERFET® III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate.

Consequently, SUPERFET III MOSFET is very suitable for the various power system for miniaturization and higher efficiency. SUPERFET III FRFET® MOSFET's optimized reverse recovery performance of body diode can remove additional component and improve system reliability.

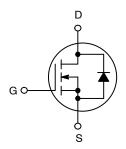
#### **Features**

- $700 \text{ V} @ \text{T}_{\text{J}} = 150^{\circ}\text{C}$
- Typ.  $R_{DS(on)} = 64 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 81 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 722 pF)
- 100% Avalanche Tested
- Qualified with AEC-Q101
- These Devices are Pb-Free and are RoHS Compliant

## **Typical Applications**

- Automotive On Board Charger
- Automotive DC/DC Converter for HEV

V <sub>(BR)DSS</sub> R <sub>DS(ON)</sub> MAX		I <sub>D</sub> MAX	
650 V	82 mΩ @ 10 V	40 A	



**N-CHANNEL MOSFET** 



D<sup>2</sup>PAK-3 TO-263 CASE 418AJ

#### **MARKING DIAGRAM**



&Z = Assembly Plant Code &3 = Data Code (Year & Week)

&K = Lot

1

NVB082N65S3F = Specific Device Code

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 7 of this data sheet.

Table 1. ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C unless otherwise stated)

Symbol	Parameter	Value	Unit	
$V_{DSS}$	Drain-to-Source Voltage	to-Source Voltage		V
$V_{GS}$	Gate-to-Source Voltage - DC		±30	V
		- AC (f > 1 Hz)	±30	
I <sub>D</sub>	Drain Current	– Continuous (T <sub>C</sub> = 25°C)	40	Α
		- Continuous (T <sub>C</sub> = 100°C)	25.5	
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)		W
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 2)	510	mJ	
I <sub>AS</sub>	Avalanche Current		4.8	Α
E <sub>AR</sub>	Repeated Avalanche Energy (Note 1)	3.13	mJ	
dv/dt	MOSFET dv/dt		100	V/ns
	Peak Diode Recovery dv/dt (Note 3)		50	
$P_{D}$	P <sub>D</sub> Power Dissipation Tc = 25°C		313	W
		- Derate Above 25°C	2.5	W/°C
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature		–55 to 150	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive rating: pulse–width limited by maximum junction temperature. 2. IAS = 4.8 A, RG = 25  $\Omega$ , starting T<sub>J</sub> = 25°C. 3. ISD  $\leq$  20 A, di/dt  $\leq$  200 A/\_s, V<sub>DD</sub>  $\leq$  400 V, starting T<sub>C</sub> = 25°C.

# **Table 2. THERMAL RESISTANCE RATINGS**

Symbol	Parameter	Max	Unit
$R_{ hetaJC}$	Thermal Resistance, Junction-to-Case, Max.	0.40	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient, Max.	40	

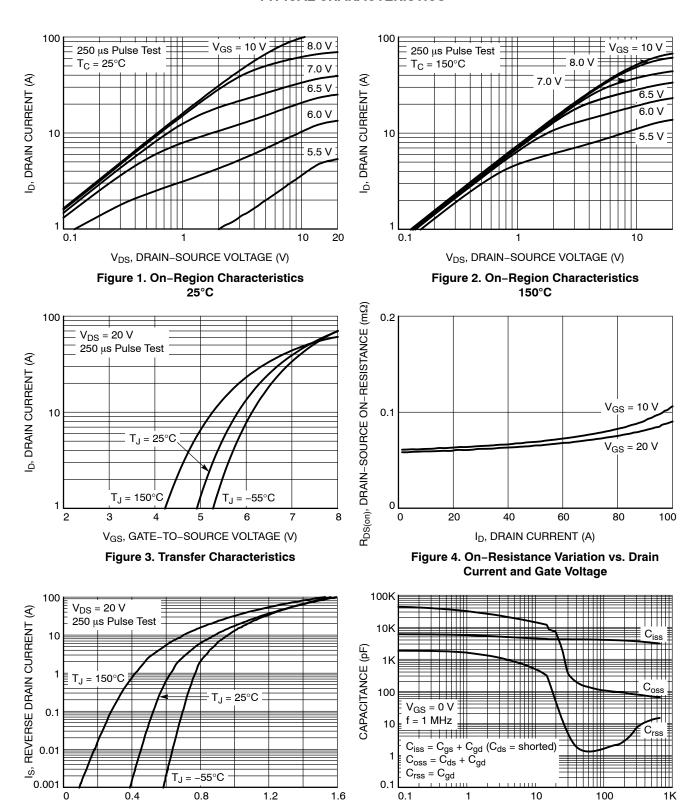
# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARAC	TERISTICS				-	-
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}, T_J = 25^{\circ}\text{C}$	650	-	_	V
		$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 150^{\circ}\text{C}$	700	-	-	V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 20 mA, Referenced to 25°C	1	0.7	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 650 V, V <sub>GS</sub> = 0 V	1	-	10	μΑ
		V <sub>DS</sub> = 520 V, T <sub>C</sub> = 125°C	-	175	-	μΑ
I <sub>GSS</sub>	Gate-to-Body Leakage Current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 30 \text{ V}$	1	-	±100	nA
ON CHARACT	ERISTICS				-	-
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$	3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain-to-Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A	-	64	82	mΩ
9FS	Forward Transconductance	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 20 A	_	24	-	S
OYNAMIC CHA	ARACTERISTICS				-	-
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	3410	_	pF
C <sub>oss</sub>	Output Capacitance		-	70	-	pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 to 400 V, V <sub>GS</sub> = 0 V	1	722	-	pF
C <sub>oss(er.)</sub>	Energy Related Output Capacitance	V <sub>DS</sub> = 0 to 400 V, V <sub>GS</sub> = 0 V	-	126	-	pF
Q <sub>g(total)</sub>	Total Gate Charge at 10 V	$V_{DS} = 400 \text{ V}, I_{D} = 20 \text{ A},$	-	81	-	nC
Q <sub>gs</sub>	Gate-to-Source Gate Charge	V <sub>GS</sub> = 10 V (Note 4)	-	24	-	пC
Q <sub>gd</sub>	Gate-to-Drain "Miller" Charge		-	32	-	nC
ESR	Equivalent Series Resistance	F = 1 MHz	-	1.9	-	Ω
WITCHING C	CHARACTERISTICS, V <sub>GS</sub> = 10 V					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 400 \text{ V}, I_D = 20 \text{ A},$	-	31	-	ns
t <sub>r</sub>	Rise Time	$V_{GS} = 10 \text{ V}, R_{G} = 4.7 \Omega$ (Note 4)	-	29	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		-	76	-	ns
t <sub>f</sub>	Fall Time		-	16	-	ns
SOURCE-DRA	AIN DIODE CHARACTERISTICS					
Is	Maximum Continuous Source-to-Drain Diode Forward Current		-	_	40	Α
I <sub>SM</sub>	Maximum Pulsed Source-to-Drain Diode Forward Current		-	-	100	Α
V <sub>SD</sub>	Source-to-Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 20 A	_	-	1.3	V
t <sub>rr</sub>	Reverse-Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 20 A,	-	108	-	ns
Q <sub>rr</sub>	Reverse-Recovery Charge	dI <sub>F</sub> /dt = 100 A/μs	-	410	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

#### TYPICAL CHARACTERISTICS



V<sub>SD</sub>, BODY DIODE FORWARD VOLTAGE (V)

Figure 5. Body Diode Forward Voltage

Variation vs. Source Current and Temperature

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 6. Capacitance Characteristics

#### **TYPICAL CHARACTERISTICS**

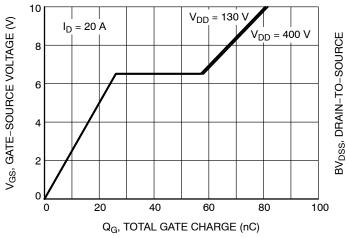


Figure 7. Gate Charge Characteristics

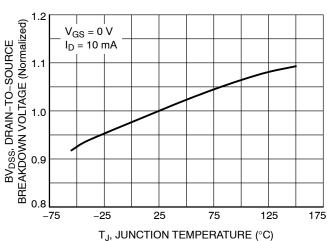


Figure 8. Breakdown Voltage Variation vs.
Temperature

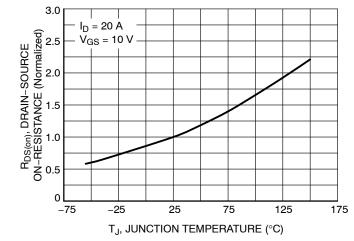


Figure 9. On-Resistance Variation vs. Temperature

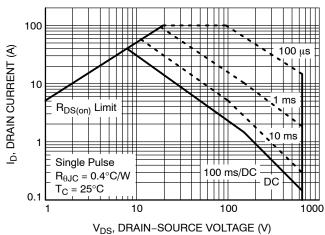


Figure 10. Maximum Safe Operating Area

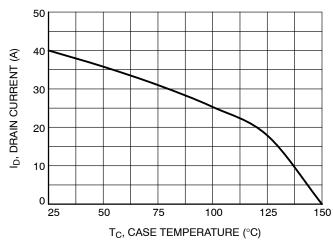


Figure 11. Maximum Drain Current vs. Case Temperature

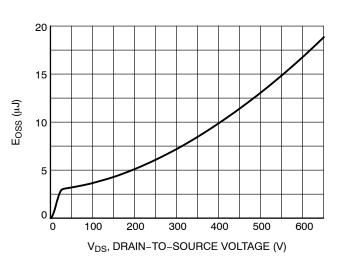
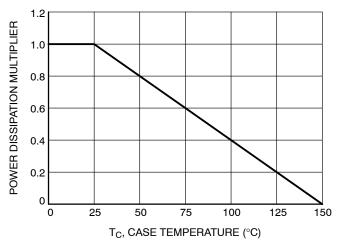


Figure 12. E<sub>OSS</sub> vs. Drain-to-Source Voltage

#### **TYPICAL CHARACTERISTICS**

1000



100 Current Limited Max 100 A

Current Limited Max 100 A

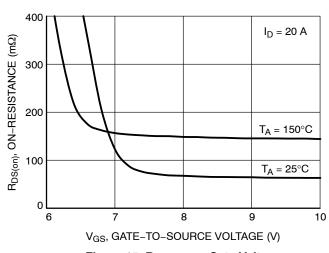
10 0.00001 0.0001 0.001 0.01 1 10

t, RECTANGULAR PULSE

Figure 13. Normalized Power Dissipation vs.

Case Temperature

Figure 14. Peak Current Capability



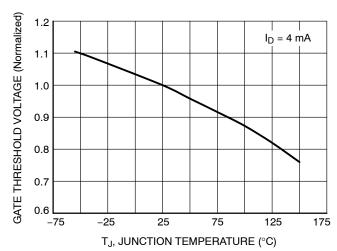


Figure 15. R<sub>DS(on)</sub> vs. Gate Voltage

Figure 16. Normalized Gate Threshold Voltage vs. Temperature

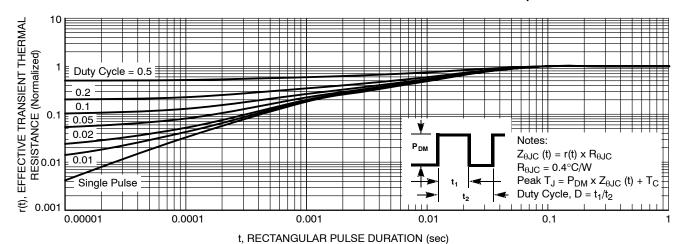


Figure 17. Transient Thermal Response

# PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
NVB082N65S3F	NVB082N65S3F	D <sup>2</sup> PAK	Tape & Reel <sup>†</sup>	330 mm	24 mm	800 Units

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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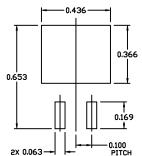




# **D<sup>2</sup>PAK-3 (TO-263, 3-LEAD)** CASE 418AJ

ISSUE F

**DATE 11 MAR 2021** 



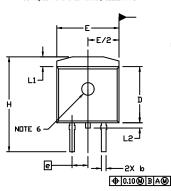
RECOMMENDED
MOUNTING FOOTPRINT

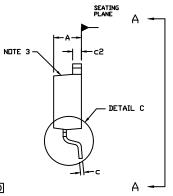
 For additional information on our Pb-Free strategy and soldering details, please downloa the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDL DERRIV/D.

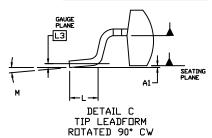
#### NOTES

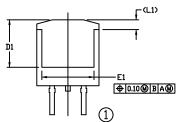
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. CHAMFER OPTIONAL
- I. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE DUTERMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- 6. OPTIONAL MOLD FEATURE.
- 7. ①,② ... OPTIONAL CONSTRUCTION FEATURE CALL DUTS.

	INCHES		MILLIN	IETERS
DIM	MIN.	MAX.	MIN.	MAX.
A	0.160	0.190	4.06	4.83
A1	0.000	0.010	0.00	0.25
ھ	0.020	0.039	0.51	0.99
u	0.012	0.029	0.30	0.74
5	0.045	0.065	1.14	1.65
D	0.330	0.380	8.38	9.65
D1	0.260		6.60	
E	0.380	0.420	9.65	10.67
E1	0.245	-	6.22	
e	0.100 BSC		2.54 BSC	
Ξ	0.575	0.625	14.60	15.88
٦	0.070	0.110	1.78	2.79
L1		0.066		1.68
L2		0.070		1.78
L3	0.010 BSC		0.25 BSC	
М	0, 8,		0*	8*

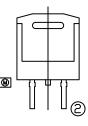


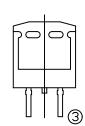


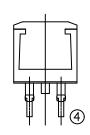




VIEW A-A







VIEW A-A

OPTIONAL CONSTRUCTIONS

# XXXXXX = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year

WW = Work Week

W = Week Code (SSG)

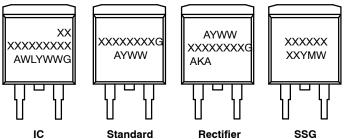
M = Month Code (SSG)

G = Pb-Free Package

AKA = Polarity Indicator

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

# GENERIC MARKING DIAGRAMS\*



DOCUMENT NUMBER:

98AON56370E

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DESCRIPTION:

D<sup>2</sup>PAK-3 (TO-263, 3-LEAD)

PAGE 1 OF 1

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